

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (U-MOSII)

TPC6002

Notebook PC Applications Portable Equipment Applications

- Low drain-source ON resistance: R_{DS} (ON) = 25 m Ω (typ.)
- High forward transfer admittance: $|\,Y_{\rm fs}\,|$ = 10 S (typ.)
- Low leakage current: $IDSS = 10 \ \mu A \ (max) \ (VDS = 30 \ V)$
- Enhancement-model: V_{th} = 1.3 to 2.5 V (V_{DS} = 10 V, I_D = 1 mA)

Maximum Ratings (Ta = 25°C)

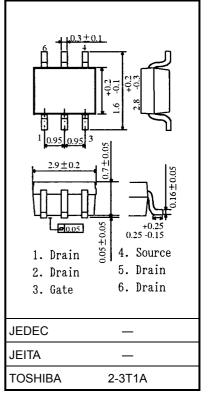
Characteristics		Symbol	Rating	Unit	
Drain-source voltage		V _{DSS}	30	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	30	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	Ι _D	6	А	
	Pulse (Note 1)	I _{DP}	24	A	
Drain power dissipation	(t = 5 s) (Note 2a)	PD	2.2	W	
Drain power dissipation	(t = 5 s) (Note 2b)	PD	0.7	W	
Single pulse avalanche ene	E _{AS}	5.8	mJ		
Avalanche current	I _{AR}	3	А		
Repetitive avalanche energ	E _{AR}	0.22	mJ		
Channel temperature	T _{ch}	150	°C		
Storage temperature range	T _{stg}	–55 to 150	°C		



Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient $(t = 5 s)$ (Note 2a)	R _{th (ch-a)}	56.8	°C/W
Thermal resistance, channel to ambient (t = 5 s) (Note 2b)	R _{th (ch-a)}	178.5	°C/W

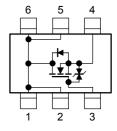
Note: (Note 1), (Note 2), (Note 3), (Note 4), (Note 5) Please see next page.

This transistor is an electrostatically sensitive device. Please handle it with caution.

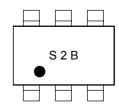


Weight: 0.011 g (typ.)

Circuit Configuration



Marking (Note 5)



Unit: mm

Electrical Characteristics (Ta = 25°C)

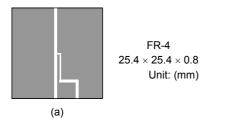
Cha	aracteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cur	rent	I _{GSS}	$V_{GS}=\pm 16~V,~V_{DS}=0~V$			±10	μA
Drain cut-OFF cu	irrent	I _{DSS}	$V_{DS} = 30 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_{D} = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30			V
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15			v
Gate threshold ve	Gate threshold voltage		$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 1 \text{ mA}$	1.3		2.5	V
Drain-source ON resistance		R _{DS (ON)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 3 \text{ A}$		36	50	mΩ
		R _{DS (ON)}	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$		25	30	
Forward transfer	admittance	Y _{fs}	$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 3 \text{ A}$	3.5	10		S
Input capacitance		C _{iss}	$V_{DS} = 10 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		610		pF
Reverse transfer capacitance		C _{rss}			105		
Output capacitance		C _{oss}			151		
Switching time	Rise time	tr	$V_{GS} \stackrel{10}{}_{0}V \int I_{D} = 3 A$	_	3	_	- ns
	Turn-ON time	t _{on}			9		
	Fall time	t _f			9		
	Turn-OFF time	t _{off}	$V_{DD}\simeq 15~V$ Duty $\leq 1\%,~t_W=10~\mu s$		27		
Total gate charge (gate-source plus gate-drain)		Qg		_	13	_	nC
Gate-source charge		Q _{gs}	$V_{DD} \simeq 24 \text{ V}, \text{ V}_{GS} = 10 \text{ V}, \text{ I}_{D} = 6 \text{ A}$		10		
Gate-drain ("miller") charge		Q _{gd}			3	_	

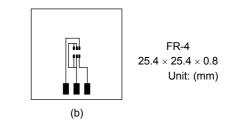
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Pulse drain reverse current	(Note 1)	I _{DRP}	_	_	_	24	А
Forward voltage (Diode)		V _{DSF}	$I_{DR} = 6 \text{ A}, \text{ V}_{GS} = 0 \text{ V}$			-1.2	V

Note 1: Please use devices on condition that the channel temperature is below 150°C.

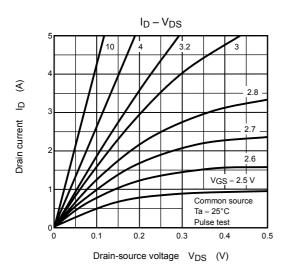
Note 2: (a) Device mounted on a glass-epoxy board (a) (t = 5 s) (b) Device mounted on a glass-epoxy board (b) (t = 5 s)

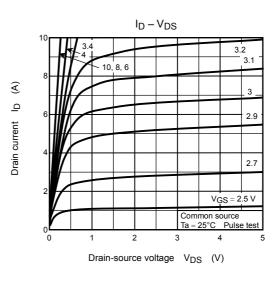


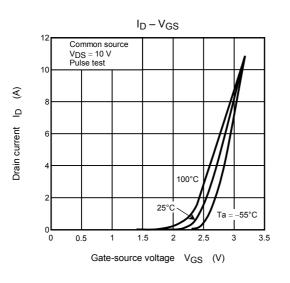


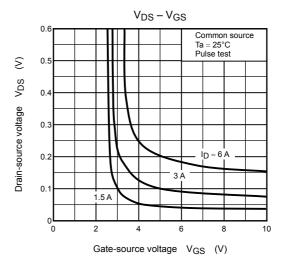
- Note 3: $V_{DD} = 24 \text{ V}, \text{ T}_{ch} = 25^{\circ}\text{C}$ (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = 3.0 A
- Note 4: Repetitive rating; pulse width limited by maximum channel temperature
- Note 5: Black round marking "•" locates on the left lower side of parts number marking "S2B" indicates terminal No.1.

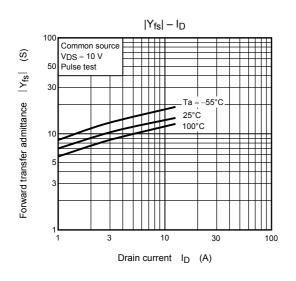
TOSHIBA

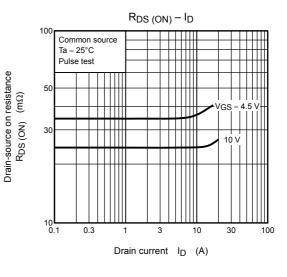




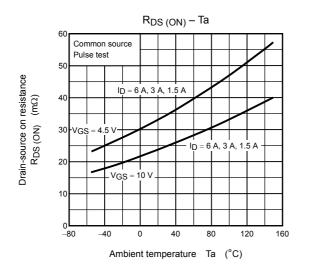


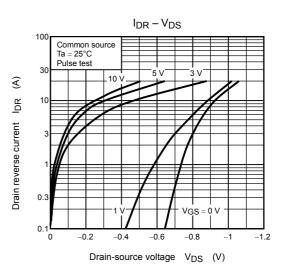


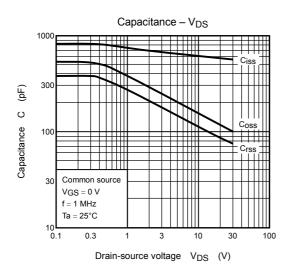


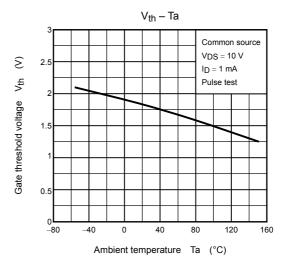


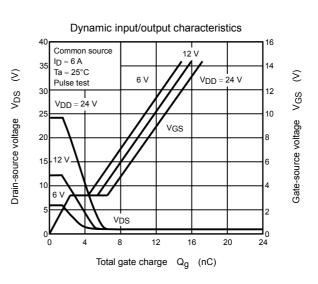
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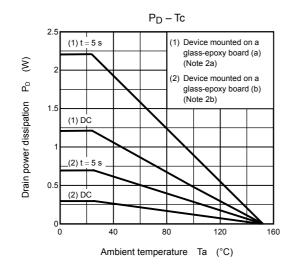


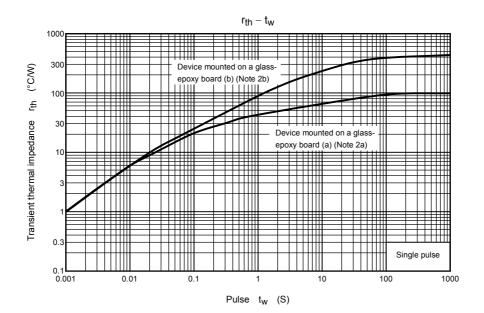




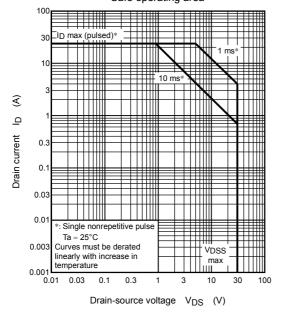








Safe operating area



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